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Application No. 09849005	Prepared by	CA	Tracking Number 0602,5377
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a. Serial No.	f. Foreign Priority	k. Print Claim(s)	(p.) PTO-1449
b. Applicant(s)	g. Disclaimer	l. Print Fig.	q. PTOL-85b
c. Continuing Data	h. Microfiche Appendix	m. Searched Column	r. Abstract
d. PCT	i. Title	n. PTO-270/328	s. Sheets/Figs
e. Domestic Priority	j. Claims Allowed	o. PTO-892	t. Other

SPECIFICATION

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b. Text Continuity
c. Holes through Data
d. Other Missing Text
e. Illegible Text
f. Duplicate Text
g. Brief Description
h. Sequence Listing
i. Appendix
j. Amendments
k. Other

CLAIMS

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RESPONSE

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PART "B"

U.S. Department of Commerce, Patent and Trademark Office	Atty Docket No.	Serial No.
	01N006-1C US	09/849,005
INFORMATION DISCLOSURE STATEMENT BY APPLICANT	Applicants: Chian-Min Ho et al.	
(Use several sheets if necessary)		
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	OINC006-1C US	09/849,005
INFORMATION DISCLOSURE STATEMENT BY APPLICANT	Applicants: Chian-Min Ho et al.	
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	OIN0061C US	09/849,005
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